Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/558,841	TOBIYAMA ET	AL.
Examiner	Art Unit	
/Yonel Beaulieu/	3661	

SEARCHED					
Class	Subclass	Date	Examiner		
701	200-202	5/31/2010	YB		
	25				
	28				
	211				
340	995.1	5/31/2010	YB		
	995.24				

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
Searched		5/31/2010	YB		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
		DATE	EXMR
WEST+Bwd/Fwd		5/31/2010	ΥB